Notice of References Cited

Application/Control No. 10/805,522	Applicant(s)/Patent Under Reexamination KIKUCHI ET AL.		
Examiner	Art Unit		
Philip H. Leuna	3742	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0186991	12-2002	Watanabe et al.	399/328
	В	US-2002/0190060	12-2002	Imai et al.	219/619
	C	US-			
	ם	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	10-91019	04-1998	JP	Sano	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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